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1,4-Bis(4-chlorophenylseleno)-2,5-dimethoxybenzene

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Key indicators: single-crystal X-ray study; T = 122 K; mean σ (C–C) = 0.003 Å; R factor = 0.028; wR factor = 0.076; data-to-parameter ratio = 16.6.

The title compound, $C_{20}H_{16}Cl_2O_2Se_2$, utilizes the symmetry of the crystallographic inversion center. Molecular chains are formed through symmetric $C-H\cdots Cl$ interactions around inversion centers, mimicking the commonly observed symmetric hydrogen-bonded dimer pattern often found in carboxylic acids.

Related literature

For background to the electrophilic arylselenylation of reactive arenes, see: Santi *et al.* (2008); Nicolaou *et al.* (1979); Gassman *et al.* (1982); Yoshida *et al.* (1991); Tiecco *et al.* (1994); Engman & Eriksson (1996); Henriksen (1994); Henriksen & Stuhr-Hansen (1998). For related structures, see: Oddershede *et al.* (2003). For related supramolecular patterns, see: Gavezzotti & Filippini (1994); Allen *et al.* (1999); Sørensen & Larsen (2003); Sørensen *et al.* (1999).



Experimental

Crystal data

 $\begin{array}{l} C_{20}H_{16}Cl_2O_2Se_2\\ M_r = 517.15\\ \text{Monoclinic, } P2_1/n\\ a = 11.7737 \ (17) \text{ Å}\\ b = 6.6535 \ (6) \text{ Å}\\ c = 13.438 \ (5) \text{ Å}\\ \beta = 114.136 \ (16)^\circ \end{array}$

 $V = 960.7 (4) Å^{3}$ Z = 2Cu Ka radiation $\mu = 7.47 \text{ mm}^{-1}$ T = 122 (1) K $0.44 \times 0.15 \times 0.13 \text{ mm}$

Data collection

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Enraf–Nonius CAD-4
diffractometer
Absorption correction: gaussian
(DeTitta, 1985).
T_{min} = 0.242, T_{max} = 0.796
2641 measured reflections
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Refinement

 $R[F^2 > 2\sigma(F^2)] = 0.028$ $wR(F^2) = 0.075$ S = 1.101976 reflections 1976 independent reflections 1919 reflections with $I > 2\sigma(I)$ $R_{int} = 0.030$ 5 standard reflections frequency: 166.7 min intensity decay: 5.7%

119 parameters H-atom parameters constrained
$$\begin{split} &\Delta\rho_{max}=0.59\ e\ \text{\AA}^{-3}\\ &\Delta\rho_{min}=-1.20\ e\ \text{\AA}^{-3} \end{split}$$

Data collection: *CAD-4 EXPRESS* (Enraf–Nonius, 1994); cell refinement: *CAD-4 EXPRESS*; data reduction: *DREAR* (Blessing, 1987); program(s) used to solve structure: *SHELXS97* (Sheldrick, 2008); program(s) used to refine structure: *SHELXL97* (Sheldrick, 2008); molecular graphics: *PLATON* (Spek, 2003); software used to prepare material for publication: *SHELXL97*.

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Supplementary data and figures for this paper are available from the IUCr electronic archives (Reference: SG2281).

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supplementary materials

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1,4-Bis(4-chlorophenylseleno)-2,5-dimethoxybenzene

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Comment

The structure of the title compound, shown in Fig. 1, crystallized in space group P $2_1/n$ utilizing the crystallography inversion center in the molecular symmetry. Generally the molecular geometry of 1 is in close agreement with the related compound 1,3-dimethoxy-4,6-bis(phenylseleno)benzene, hereafter DMPSB. All bond distances and angles are the same within the experimental uncertainty. The molecular conformation of 1 is also very similar to the chloro-unsubstituted compound DMPSB having the planes of phenylseleno groups arranged perpendicular to the plane of the central benzene moiety, but rotated in opposite directions forming a *Z* like conformation (Fig. 1). Leading to the formation of intramolecular C_{ar} —H··· π interactions.

The molecular packing arrangement is dominated by molecular chains (see Fig. 2) formed by cyclic C_{ar} —H···Cl interactions [H7···Cl_i = 2.96 Å, C7—H7···Cl_i = 166.0°; symmetry code: (i) 2 - *x*,1 - *y*,1 - *z*] around an inversion center leading to a pattern, which highly resembles the cyclic hydrogen-bonded dimers frequently observed in carboxylic acids. The C_{ar} —H···Cl type of cyclic interaction found in 1 has also been observed in other compounds having a *p*-chlorosubstituted phenyl group, *e.g.* in the structure of racemic *p*-chlorophenoxypropionic acid, where the distance H···Cl is 2.92 Å [C—H···Cl 175°]. The chains are stacked such that the π - π interactions between the phenelseleno groups and between the benzene rings along the diagonal of the b and c-axes, respectively. Due to the chain formation in 1 the packing arrangement is rather different from the pattern found in DMPSB, where interactions with chlorine cannot be formed.

Experimental

Crystals suitable for an X-ray diffraction experiment were obtained by slow crystallization from hot toluene.

Refinement

Hydrogen atoms of (1) were found in the difference Fourier map. All hydrogen atoms were treated as riding atoms with C—H distances of 0.95 for C_{ar} and 0.98 for the C_{Me} . Isotropic displacement parameters for all H atoms were constrained to $1.2U_{eq}$ of the connected non-hydrogen atom ($1.5U_{eq}$ for Me groups).

Figures



Fig. 1. Thermal elipsoid plot of (1) including labelling of the atoms. The displacement ellipsoids are drawn at the 50% probability level. H atoms are shown as spheres with an arbitrary radii.



Fig. 2. A view of the cyclic C—H···Cl interactions linking the molecules into a chain.

Fig. 3. Packing diagram of viewed down the *b* axis.

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Crystal data	
$\mathrm{C_{20}H_{16}Cl_2O_2Se_2}$	$F_{000} = 508$
$M_r = 517.15$	$D_{\rm x} = 1.788 { m Mg m}^{-3}$
Monoclinic, $P2_1/n$	Melting point: 193 K
Hall symbol: -P 2yn	Cu K α radiation $\lambda = 1.54184 \text{ Å}$
a = 11.7737 (17) Å	Cell parameters from 20 reflections
<i>b</i> = 6.6535 (6) Å	$\theta = 39.3 - 40.7^{\circ}$
c = 13.438 (5) Å	$\mu = 7.47 \text{ mm}^{-1}$
$\beta = 114.136 \ (16)^{\circ}$	T = 122 (1) K
$V = 960.7 (4) \text{ Å}^3$	Block, white
<i>Z</i> = 2	$0.44 \times 0.15 \times 0.13 \text{ mm}$

Data collection

$R_{\text{int}} = 0.030$
$\theta_{\text{max}} = 74.9^{\circ}$
$\theta_{\min} = 4.2^{\circ}$
$h = -14 \rightarrow 14$
$k = -7 \rightarrow 8$
$l = 0 \rightarrow 16$
5 standard reflections
every 166.7 min
intensity decay: 5.7%

Refinement

Refinement on F^2	Hydrogen site location: difference Fourier map
Least-squares matrix: full	H-atom parameters constrained

$R[F^2 > 2\sigma(F^2)] = 0.028$	$w = 1/[\sigma^2(F_o^2) + (0.0433P)^2 + 0.9774P]$ where $P = (F_o^2 + 2F_c^2)/3$
$wR(F^2) = 0.076$	$(\Delta/\sigma)_{\rm max} < 0.001$
<i>S</i> = 1.10	$\Delta \rho_{max} = 0.60 \text{ e } \text{\AA}^{-3}$
1976 reflections	$\Delta \rho_{\rm min} = -1.20 \text{ e } \text{\AA}^{-3}$
119 parameters	Extinction correction: SHELXL97 (Sheldrick, 2008), $Fc^*=kFc[1+0.001xFc^2\lambda^3/sin(2\theta)]^{-1/4}$
Primary atom site location: structure-invariant direct methods	Extinction coefficient: 0.0029 (3)

Secondary atom site location: difference Fourier map

Special details

Geometry. All e.s.d.'s (except the e.s.d. in the dihedral angle between two l.s. planes) are estimated using the full covariance matrix. The cell e.s.d.'s are taken into account individually in the estimation of e.s.d.'s in distances, angles and torsion angles; correlations between e.s.d.'s in cell parameters are only used when they are defined by crystal symmetry. An approximate (isotropic) treatment of cell e.s.d.'s is used for estimating e.s.d.'s involving l.s. planes.

Refinement. Refinement of F^2 against ALL reflections. The weighted *R*-factor *wR* and goodness of fit *S* are based on F^2 , conventional *R*-factors *R* are based on *F*, with *F* set to zero for negative F^2 . The threshold expression of $F^2 > \sigma(F^2)$ is used only for calculating *R*-factors(gt) *etc.* and is not relevant to the choice of reflections for refinement. *R*-factors based on F^2 are statistically about twice as large as those based on *F*, and *R*- factors based on ALL data will be even larger.

	x	у	Ζ	$U_{\rm iso}*/U_{\rm eq}$
Se1	0.745362 (19)	0.19839 (3)	0.007848 (17)	0.01812 (12)
Cl	1.00097 (5)	0.82041 (8)	0.40315 (5)	0.02427 (15)
01	1.23891 (13)	0.1213 (2)	0.13084 (12)	0.0192 (3)
C1	1.2567 (2)	0.2869 (3)	0.20396 (19)	0.0232 (5)
H1A	1.3459	0.3140	0.2431	0.035*
H1B	1.2213	0.2535	0.2564	0.035*
H1C	1.2150	0.4063	0.1623	0.035*
C2	1.11846 (19)	0.0668 (3)	0.06767 (16)	0.0160 (4)
C3	1.0144 (2)	0.1577 (3)	0.07253 (17)	0.0168 (4)
Н3	1.0245	0.2653	0.1219	0.020*
C4	0.89557 (19)	0.0910 (3)	0.00514 (16)	0.0159 (4)
C5	0.82080 (19)	0.3830 (3)	0.12694 (17)	0.0172 (4)
C6	0.8614 (2)	0.3181 (3)	0.23448 (19)	0.0194 (4)
H6	0.8506	0.1815	0.2493	0.023*
C7	0.9173 (2)	0.4513 (3)	0.32023 (17)	0.0197 (4)
H7	0.9457	0.4067	0.3936	0.024*
C8	0.93109 (19)	0.6504 (3)	0.29699 (17)	0.0174 (4)
C9	0.8891 (2)	0.7196 (3)	0.19057 (19)	0.0211 (5)
Н9	0.8985	0.8570	0.1762	0.025*
C10	0.8331 (2)	0.5850 (3)	0.10537 (17)	0.0201 (4)
H10	0.8030	0.6308	0.0321	0.024*

Fractional atomic coordinates and isotropic or equivalent isotropic displacement parameters (A^2)

supplementary materials

Atomic displacement parameters $(Å^2)$

	U^{11}	U^{22}	U^{33}	U^{12}	U^{13}	U^{23}
Se1	0.01674 (16)	0.01956 (17)	0.01817 (16)	0.00021 (7)	0.00723 (11)	-0.00363 (7)
Cl	0.0267 (3)	0.0243 (3)	0.0206 (3)	-0.0041 (2)	0.0084 (2)	-0.00601 (18)
O1	0.0174 (7)	0.0196 (7)	0.0194 (7)	-0.0023 (6)	0.0063 (6)	-0.0059 (6)
C1	0.0242 (11)	0.0227 (11)	0.0217 (11)	-0.0045 (9)	0.0084 (9)	-0.0084 (8)
C2	0.0178 (9)	0.0154 (9)	0.0145 (9)	-0.0025 (8)	0.0064 (7)	0.0012 (7)
C3	0.0215 (10)	0.0136 (9)	0.0164 (9)	-0.0016 (8)	0.0089 (8)	-0.0014 (7)
C4	0.0192 (9)	0.0143 (9)	0.0156 (9)	0.0004 (7)	0.0084 (8)	0.0013 (7)
C5	0.0169 (9)	0.0178 (10)	0.0196 (10)	0.0013 (8)	0.0103 (8)	-0.0016 (8)
C6	0.0211 (10)	0.0160 (10)	0.0216 (11)	0.0022 (8)	0.0091 (9)	0.0024 (8)
C7	0.0208 (10)	0.0215 (11)	0.0170 (9)	0.0033 (8)	0.0080 (8)	0.0037 (8)
C8	0.0169 (9)	0.0173 (10)	0.0189 (10)	0.0001 (8)	0.0080 (8)	-0.0038 (8)
C9	0.0255 (11)	0.0163 (10)	0.0213 (11)	-0.0001 (8)	0.0093 (9)	0.0018 (8)
C10	0.0245 (11)	0.0196 (10)	0.0170 (10)	0.0017 (8)	0.0093 (8)	0.0031 (8)
Geometric paran	neters (Å, °)					
Se1—C4		1.921 (2)	C4—C	2^{i}	1.398	(3)
Se1—C5		1.923 (2)	С5—С	6	1,393 (3)	
Cl—C8		1.741 (2)	C5—C10		1.395 (3)	
O1—C2		1.371 (2)	C6—C7		1.388 (3)	
O1—C1		1.433 (2)	С6—Н	6	0.9500	
C1—H1A		0.9800	C7—C8		1.386 (3)	
C1—H1B		0.9800	С7—Н	7	0.9500	
C1—H1C		0.9800	C8—C9		1.387 (3)	
C2—C3		1.391 (3)	C9—C10		1.389 (3)	
C2—C4 ⁱ		1.398 (3)	С9—Н9		0.9500	
C3—C4		1.392 (3)	C10—H10		0.9500	
С3—Н3		0.9500				
C4—Se1—C5		97.92 (9)	С6—С	5—Se1	120.74 (16)	
C2C1		116.88 (17)	C10—C5—Se1		119.64 (16)	
O1—C1—H1A		109.5	C7—C6—C5		120.6 (2)	
O1—C1—H1B		109.5	С7—С6—Н6		119.7	
H1A—C1—H1B		109.5	С5—С6—Н6		119.7	
01—C1—H1C		109.5	C8—C7—C6		118.9 (2)	
H1A—C1—H1C		109.5	C8—C	7—Н7	120.6	
H1B—C1—H1C		109.5	С6—С7—Н7		120.6	
O1—C2—C3		124.29 (19)	C7—C8—C9		121.7 (2)	
01—C2—C4 ⁱ		115.37 (18)	C7—C8—Cl		119.75 (17)	
C3—C2—C4 ⁱ	120.34 (19) C9—C8—Cl		C9—C8—Cl		118.60	0 (17)
C2—C3—C4		120.07 (19)	C8—C	9—C10	119.0	(2)
С2—С3—Н3		120.0	C8—C	9—Н9	120.5	
С4—С3—Н3		120.0	C10—0	С9—Н9	120.5	
C3—C4—C2 ⁱ		119.60 (19)	С9—С	10—C5	120.3	(2)
C3-C4-Se1		123.88 (16)	С9—С	10—H10	119.9	

C2 ⁱ —C4—Se1	116.50 (15)	С5—С10—Н10	119.9
C6—C5—C10	119.6 (2)		
C1—O1—C2—C3	-1.8 (3)	C10—C5—C6—C7	-2.0 (3)
C1—O1—C2—C4 ⁱ	178.06 (18)	Se1—C5—C6—C7	179.10 (16)
O1—C2—C3—C4	-179.78 (19)	C5—C6—C7—C8	0.6 (3)
C4 ⁱ —C2—C3—C4	0.4 (3)	C6—C7—C8—C9	0.8 (3)
$C2-C3-C4-C2^{i}$	-0.4 (3)	C6—C7—C8—Cl	179.98 (16)
C2-C3-C4-Se1	177.83 (15)	C7—C8—C9—C10	-0.7 (3)
C5—Se1—C4—C3	-3.27 (19)	Cl-C8-C9-C10	-179.91 (17)
C5—Se1—C4—C2 ⁱ	174.97 (16)	C8—C9—C10—C5	-0.8 (3)
C4—Se1—C5—C6	-83.67 (18)	C6—C5—C10—C9	2.1 (3)
C4—Se1—C5—C10	97.46 (18)	Se1-C5-C10-C9	-179.02 (17)
Symmetry codes: (i) $-x+2$, $-y$, $-z$.			

Fig. 1





Fig. 2



